

Notice of References Cited

Application/Control No.

10/659,271

Applicant(s)/Patent Under

Reexamination

YAGUCHI ET AL.

Examiner

John L. Goodrow

Art Unit

1756

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-6,677,093 | 01-2004 | Yoshino et al. | 430/106.2 |
| * | B | US-6,130,017 | 10-2000 | Hayashi et al. | 430/108.3 |
| * | C | US-2004/0043317 | 03-2004 | Yaguchi et al. | 430/108.8 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | JP 2000-319021 | 04-1999 | Japan | | |
| | O | JP 2002-129063 | 09-2002 | Japan | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.